

Eagle

2023.03 Mass production inspection

SH Son

Model Name: BFX-AT100

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Document History

Version	Editor	Date	Updates
001	SH Son (Seunghwan Son)	2023.03.27	initial version

- SKB incoming inspection
 - Inspection lot : BFX-AT100 28k delivered on 2023.03
 - Sampling size : AQL 0.15 (1600pcs)
 - Date : 2023.03.09 ~ 2023.03.15
 - Location : [SK networks warehouse](#), Anseong, Korea.
- Overall inspection result
 - Pass
- Defect Total
 - Minor
 - Carton label damaged* 1 pcs

Definition*

- Critical : The **defect related to product functions**
- Major : The defect is no effect on the product functions. But **visually defect**. (i.g cosmetic damaged.)
- Minor : The defect is no effect on the product functions, no visually defect. But **need improvement**

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Carton label damaged

- Issue grade : Minor
 - Defect unit Q'ty : 1box / 160box
 - Carton ID :214CY103060318
- Symptom
 - Carton Label damaged – can't read barcode
- ALT initial review
 - Visual check : NG
- Action item
 - FXN should be submit FA report
 - Find The root cause.
 - Provide the preventive action



Thank you.

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